

Test report of

In Situ Temperature Measurement

And Lumen Maintenance Projection

Rendered to:

LIGHT EFFICIENT DESIGN, DIV OF TADD LLC. 188 S. Northwest Highway Cary, IL 60013

For products: LED Lamp

Models:

LED-8032M40-MHBC

Test date: Sep. 17, 2016

Test laboratory: LCTECH (Zhongshan) Testing Service Co.,Ltd

2/F., Technology and Enterprise Development Center, Guangyuan Road, Xiaolan,

Zhongshan, Guangdong, China

Bowen Pang

Laboratory note:

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Sep. 27, 2016

Reviewed by:

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Sep. 27, 2016

Double

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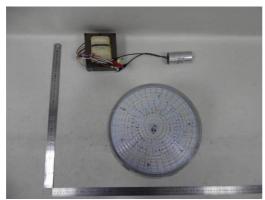
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1 General

1.1 Products Information

Brand Name	-
Lamp Type	LED Lamp
Model Number	LED-8032M40-MHBC
Rated Inputs	277V, 60Hz
Rated Power	210 W
Rated Initial Lamp Lumens	N/A
Declared CCT	4000K
Ballast	M59
LED Package, Array or Module	Model: SPMWHX1228FXXXXXXXX, manufactured by SAMSUNG
	ELECTRONICS CO., LTD
Date of Receipt Samples	Sep. 7, 2016
Quantity of Receipt Samples	1 units
	·

Photo





Picture 1 Picture 2





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1.2 Reference standards or methods

The following standards are partly or totally used or referenced for test:

No.	Name
IEC 62560-2011#	Self-ballasted LED-lamps for general lighting services by
	voltage>50V- Safety specifications
IES LM-80-08	Approved Method for Measuring Lumen Maintenance of LED Light
	Sources
IES TM-21-2011	Projecting Long Term Lumen Maintenance of LED Sources
IES LM-84-14 Annex A	Recommendations for measurement of In-situ conditions LED
	case Temperature, Ts

^{**}Note: Standard IEC 62560-2011 only clause 10 cap temperature rise was tested . For reference only and IEC 62560-2011 is not in the scope of NVLAP recognition.

1.3 Equipment list

ID	Instrument	Model name	Cal. Date	Next cal. Date
AC Power supply	LC-I-923	CHP-500	2016-02-04	2017-02-03
AC Power supply	LC-I-987	APW-110N	2016-02-04	2017-02-03
Power analyzer	LC-I-954	WT210	2016-02-04	2017-02-03
Multimeter	LC-I-972	Fluke 17B	2016-08-10	2017-08-09
J thermocouple	LC-I-096	TT-J-30-SLE(200m/r)	2016-03-01	2017-02-28
Data acquisition/Switch unit	LC-I-098	34970A	2016-03-01	2017-02-28
Wireless T&H Transmitter	LC-I-978	DWRF-B	2016-02-03	2017-02-28





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2 Test conducted and method

2.1 Ambient Condition

Test was conducted in an ambient temperature of 25 \pm 5 °C. Ambient temperature variations above or below 25 °C was subtracted from or added to temperatures recorded at points on the luminaire. The ambient temperature was measured by a thermocouple which was immersed in 15 ml of mineral oil

2.2 Temperature Stabilization

Temperatures were measured after they have stabilized when the temperature were changing at a rate less than 1°C per hour and would not rise.

2.3 Thermocouples

in a glass container.

Type J thermocouple was used for temperature measurement. The diameter of thermocouple conductor was 0.05mm².

2.4 Draught-free test enclosure

The lamp was positioned in a rectangular draught-proof enclosure with a double skin on the top and on at least three sides, and with a solid base. The double skins were of perforated metal, spaced apart approximately 150mm, with regular perforations of 1 mm to 2 mm diameter, occupying about 40% of the whole area of each skin. The internal surfaces of enclosure are painted with a matt paint.

2.5 Suspension methods

The luminaire was suspended in the ceiling of draught-free test enclosure.

2.6 Thermocouples contact

Thermocouples were in contact with the TMP_{LED} location described in LM-80 test report. In order to gain the maximum temperature, if appropriate, more than one thermocouple was contact in these locations. For details information, please refer to clause 3.3 for the photo of thermocouple contact.





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3 Test Result

3.1 Electrical data

Criteria Item	Result
Input voltage	277.00V~60Hz
Input current	1.298 A
Total power	208.82 W
Power factor	0.581

3.2 Temperature data

Criteria Item	Result
Total operated period	8.0 hours
Ambient temperature	25.4°C
Measured maximum Temperature @TMP _{LED}	77.8C
Maximum Temperature @TMP _{LED} (Normalized to 25°C)	<u>77.4°C</u>

Note: TMP_{LED} was the maximum temperature LED which was selected based on the method of Annex A of IES LM-84-14

3.3 Lumen Maintenance Projection (IESNA TM-21 Method)

Criteria Item	Result
6000 hours lumen maintenance of LED light source	94.20%
forward current on each LED light source	150 mA
Projected L ₇₀ lumen maintenance life	<u>51000 hours</u>
Reported L ₇₀ lumen maintenance life	<u>51000 hours</u>

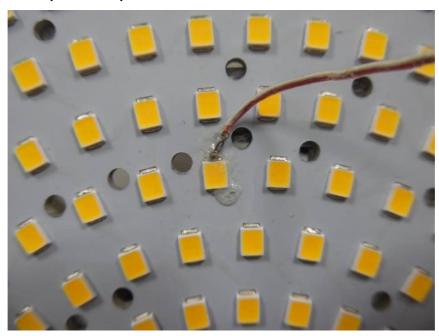
Note: Please refer to appendix 2 and 3 for details of TM-21 inputs and results.



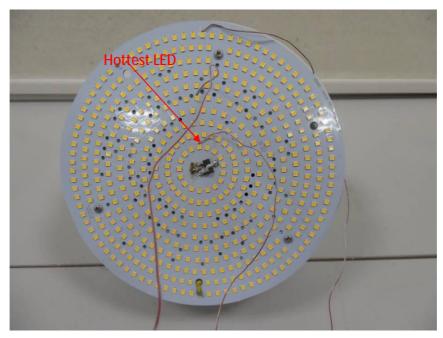


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3.4 Thermocouple contact photo



Picture 1 Part view of hottest LED



Picture 2 Over view





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Appendix 1 LM-80 report summary

• • • • • • • • • • • • • • • • • • • •	•		
Report originated by	Shenz	hen BST Technology Co.	, Ltd.
Manufactured by	SAMSU	JNG ELECTRONICS CO	., LTD
LM-80 report No.	BS.	T1510440900002Y- 1SR-	· 2
LED Model	SF	PMWHX1228FXXXXXXX	X
LED Part Number	SF	PMWHX1228FXXXXXXX	X
Number of LED light source tested		20 units	
Drive Current		150 mA	
Case temperature	55°C	75°C	85°C
10000 hours lumen maintenance	94.20%	94.04%	90.57%
10000 hours color	0.0042	0.0052	0.0050
maintenance(Δu'v')	0.0042	0.0052	0.0059



Appendix 2 TM-21 inputs

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Ref No

TM-21 Inputs

		LM-8	LM-80 Test Inputs				
Description of LED Light Source Tested (manufacturer, model, catalog number)	bq (1)	Test D	Test Data for 55°C Case Temperature	Test	Test Data for 85°C Case Temperature	Test D	Test Data for 105°C Case Temperature
Model: SPMWHX1228FXXXXXXXX, manufactured by SAMSUNG ELECTRONICS CO., LTD	IN SAMSUNG	Time (hours)	Lumen Maintenance (%)	Time (hours)	Lumen Maintenance (%)	Time (hours)	Lumen Maintenance (%)
		0	100 00%	0	100 00%	0	100 00%
		1000	100.00%	1000	%06.66	1000	99.50%
		2000	99.61%	2000	98.84%	2000	98.33%
		3000	98.81%	3000	98.26%	3000	97.35%
		4000	98.35%	4000	97.77%	4000	96.44%
LM-80 Testing Details		2000	97.79%	2000	97.36%	2000	95.63%
Total number of units tested per case temperature:	20	0009	97.34%	0009	96.72%	0009	94.81%
Number of failures:	0	7000	%00'.26	7000	95.74%	7000	92.70%
Number of units measured:	20	8000	96.42%	8000	94.69%	8000	92.22%
Test duration (hours):	10000	0006	95.49%	0006	94.51%	0006	91.44%
Tested drive current (mA):	150	10000	94.20%	10000	94.04%	10000	90.57%
Tested case temperature 1 (T _o , ⁰ C):	55						
Tested case temperature 2 (T _c , ⁰ C):	85						
Tested case temperature 3 (T _c , ^o C):	105						
In-Situ Inputs							

Densils: vest unation inters or an eleast 6,000 hours. If only one case temperature data set is to be used (no interpolation), complete only "fested case temperature 1". For only two case temperature data sets, complete 1 and 2.

First, enter a description of the LED light source tested. Then complete the fields labeled "LM-80 Testing Details". Test duration must be at

Yellow fields are completed by the user. Fields not used should be left blank. Cyan fields are calculated based on user entries.

Next, further to the right, in the corresponding box(es) for each tested case temperature, enter the test data along with the time (in hours) at which each measurement was taken. Data entered must be normalized then averaged measured data (per TM-21 sections 5.2.1 and 5.2.2).

Drive current for each LED package/array/module (mA): 150 In-situ case temperature (T_o·O₂): 77.4 Percentage of initial lumens to project to (e.g. for 70):

Results can be tailored to estimate lumen maintenance at a specific time by entering a value (t) in the yellow

A complete TM-21 report will appear on the next tab labeled "Report".

Enter drive current, in-situ temperature data and the percentage of initial lumens to project to in the fields labeled "In-Situ Inputs".

Results	
Time (t) at which to estimate lumen maintenance	
(hours):	
Lumen maintenance at time (t) (%):	94.2
Calculated L70 (hours):	
Reported L70 (hours):	

10,000

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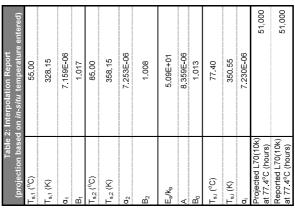


Appendix 3 TM-21 Results

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Ref. No.

TM-21 Report



	Tat	Table 1: Report at each LM-80 Test Condition	80 Test Conditio	ū		
Description of LED Light Source Tested (manufacturer, model, catalog number)	nt Source Tested , model, nber)	Model: SPMWHX1228FX)	<xxxxx, manu<="" th=""><th>Model: SPMWHX1228FXXXXXXX, manufactured by SAMSUNG ELECTRONICS C</th><th>ECTRONICS O</th><th>(projection T_{s,1} (°C) T_{s,1} (K)</th></xxxxx,>	Model: SPMWHX1228FXXXXXXX, manufactured by SAMSUNG ELECTRONICS C	ECTRONICS O	(projection T _{s,1} (°C) T _{s,1} (K)
Test Condition 1 - 55°C Case Temp	C Case Temp	Test Condition 2 - 85°C Case Temp	Case Temp	Test Condition 3 - 105°C Case Temp	C Case Temp	α,
Sample size	20	Sample size	20	Sample size	20	B,
Number of failures	0	Number of failures	0	Number of failures	0	T _{s,2} (°C)
DUT drive current used in the test (mA)	150	DUT drive current used in the test (mA)	150	DUT drive current used in the test (mA)	150	T _{s,2} (K)
Test duration (hours)	10,000	Test duration (hours)	10,000	Test duration (hours)	10,000	\mathfrak{a}_2
Test duration used for projection (hour to hour)	5,000 - 10,000	Test duration used for projection (hour to hour)	5,000 - 10,000	Test duration used for projection (hour to hour)	5,000 - 10,000	B ₂
Tested case temperature (°C)	55	Tested case temperature (°C)	85	Tested case temperature (°C)	105	E _a /k _b
	7.159E-06	ø	7,253E-06	p	1.102E-05	¥
8	1.017	В	1.008	a	1.009	B ₀
Calculated L70(10k) (hours)	52,000	Calculated L70(10k) (hours)	20,000	Calculated L70(10k) (hours)	33,000	T _{s,i} (°C)
Reported L70(10k)	52,000	Reported L70(10k)	50,000	Reported L70(10k)	33,000	T _{s,i} (K)

Notes: N.A		
Report Generated By: Bowen Pang	Company: LCTECH (Zhongshan) Testing Service Co.,Ltd.	Date:Sep. 21, 2016

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****End of test report****